

N-CHANNEL SILICON POWER MOSFET

F- I SERIES

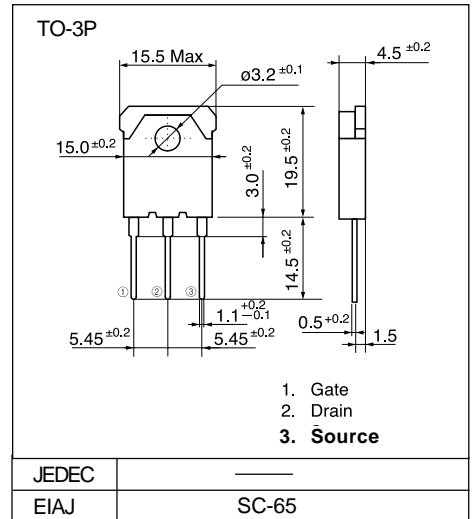
Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- High voltage

Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters
- General purpose power amplifier

Outline Drawings

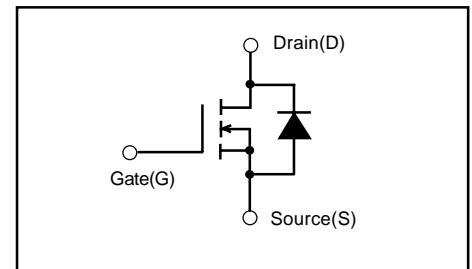


Maximum ratings and characteristics

Absolute maximum ratings (T_c=25°C unless otherwise specified)

| Item | Symbol | Rating | Unit |
|---|-------------------------------------|---------------------|------|
| Drain-source voltage | V _{DS} | 500 | V |
| Continuous drain current | I _D | 10 | A |
| Pulsed drain current | I _{D(puls)} | 40 | A |
| Continuous reverse drain current | I _{DR} | 10 | A |
| Gate-source peak voltage | V _{GS} | ±20 | V |
| Max. power dissipation | P _D | 100 | W |
| Operating and storage temperature range | T _{ch} T _{stg} | +150 -55 to +150 | °C |

Equivalent circuit schematic



Electrical characteristics (T_c =25°C unless otherwise specified)

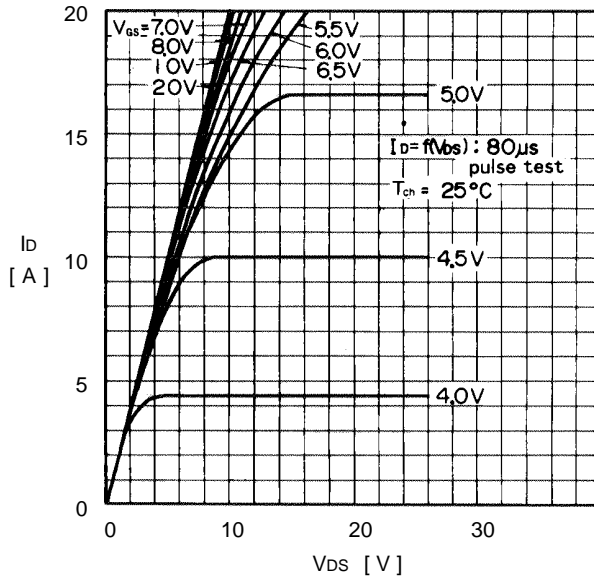
| Item | Symbol | Test Conditions | Min. | Typ. | Max. | Units | |
|--|--|---|------|-------------------|-------------------|-------|----|
| Drain-source breakdown voltage | V _{(BR)DSS} | I _D =1mA V _{GS} =0V | 500 | | | V | |
| Gate threshold voltage | V _{GS(th)} | I _D =10mA V _{DS} =V _{GS} | 2.1 | 3.0 | 4.0 | V | |
| Zero gate voltage drain current | I _{DSS} | V _{DS} =500V V _{GS} =0V T _{ch} =25°C | | 10 | 500 | μA | |
| Gate-source leakage current | I _{GSS} | V _{GS} =±20V V _{DS} =0V | | 10 | 100 | nA | |
| Drain-source on-state resistance | R _{DS(on)} | I _D =5A V _{GS} =10V | | 0.5 | 0.67 | Ω | |
| Forward transconductance | g _{fs} | I _D =5A V _{DS} =25V | 6.0 | 10.0 | | S | |
| Input capacitance | C _{iss} | V _{DS} =25V | | 1600 | 2400 | pF | |
| Output capacitance | C _{oss} | V _{GS} =0V | | 200 | 300 | | |
| Reverse transfer capacitance | C _{rss} | f=1MHz | | 80 | 120 | | |
| Switching time (t _{off} =t _{d(off)} +t _r) | t _{on} t _{d(off)} t _r | V _{CC} =30V R _G =50 Ω I _D =2.8A V _{GS} =10V | | 130 330 110 | 195 430 140 | ns | |
| Diode forward on-voltage | V _{SD} | I _F =2×I _{DR} V _{GS} =0V T _{ch} =25°C | | 1.1 | 1.7 | | V |
| Reverse recovery time | t _{rr} | I _F =I _{DR} di/dt=100A/μs T _{ch} =25°C | | 500 | | | ns |

Thermal characteristics

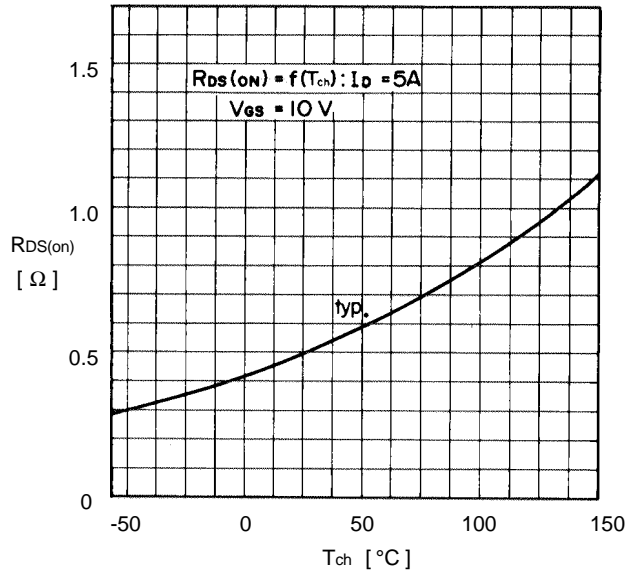
| Item | Symbol | Test Conditions | Min. | Typ. | Max. | Units |
|--------------------|-----------------------|--------------------|------|------|------|-------|
| Thermal resistance | R _{th(ch-a)} | channel to ambient | | | 35 | °C/W |
| | R _{th(ch-c)} | channel to case | | | 1.25 | °C/W |

Characteristics

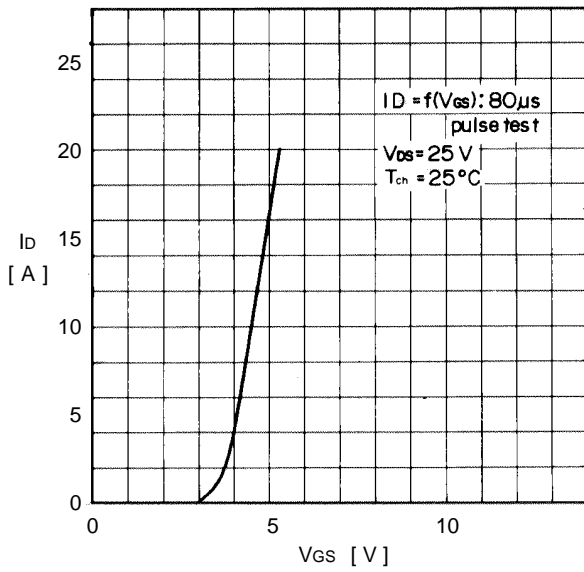
Typical output characteristics



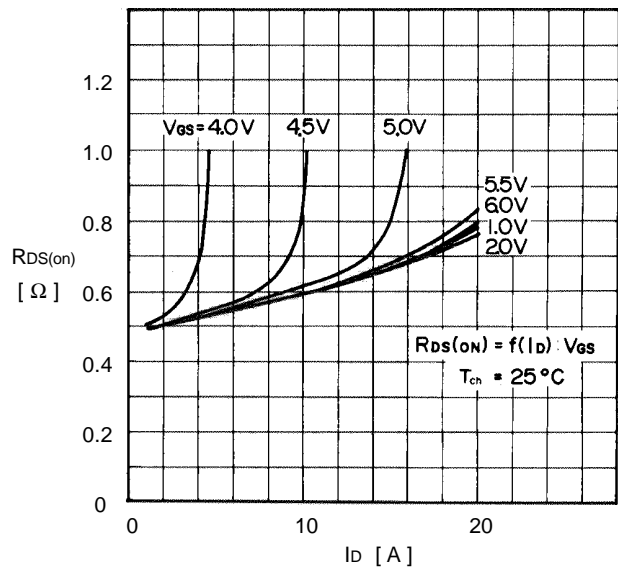
On state resistance vs. T_{ch}



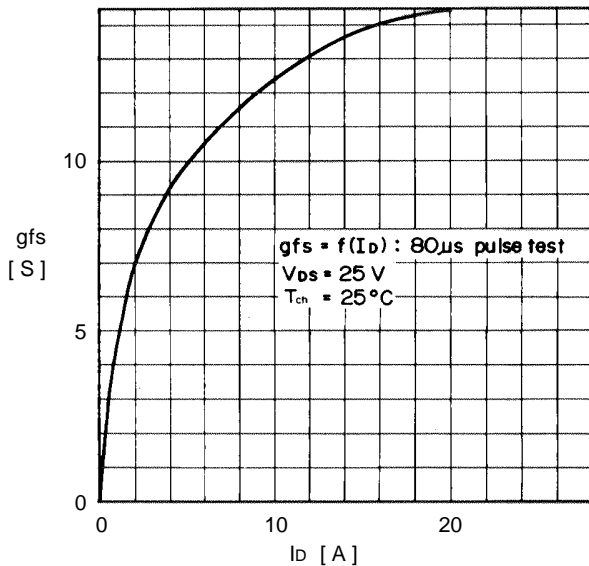
Typical transfer characteristics



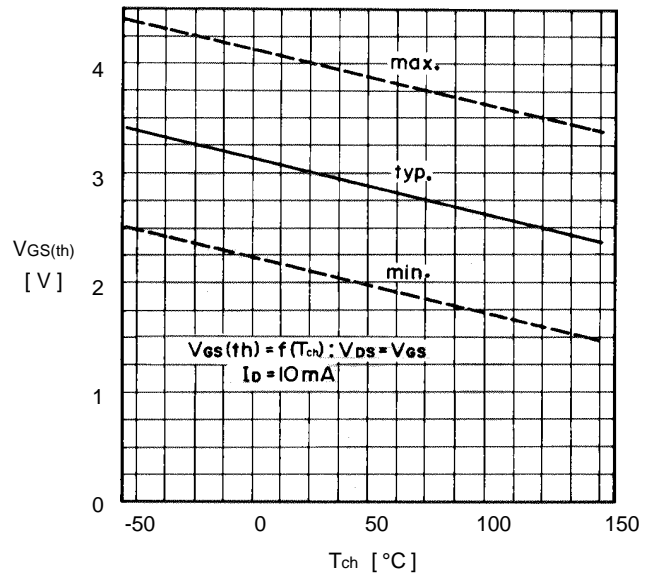
Typical Drain-Source on state resistance vs. I_D



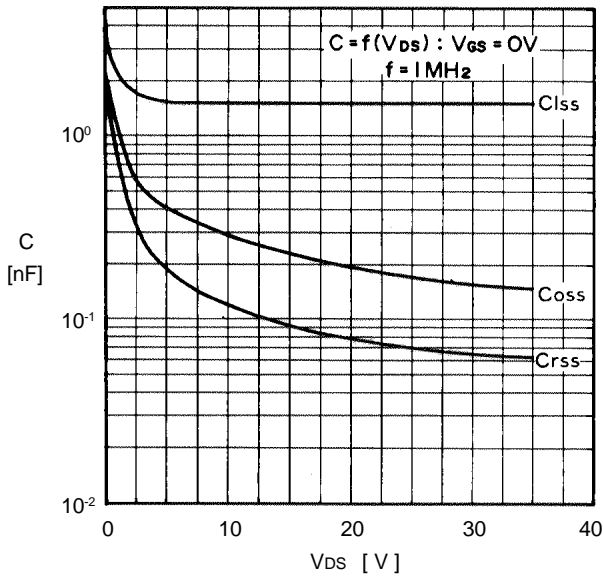
Typical forward transconductance vs. I_D



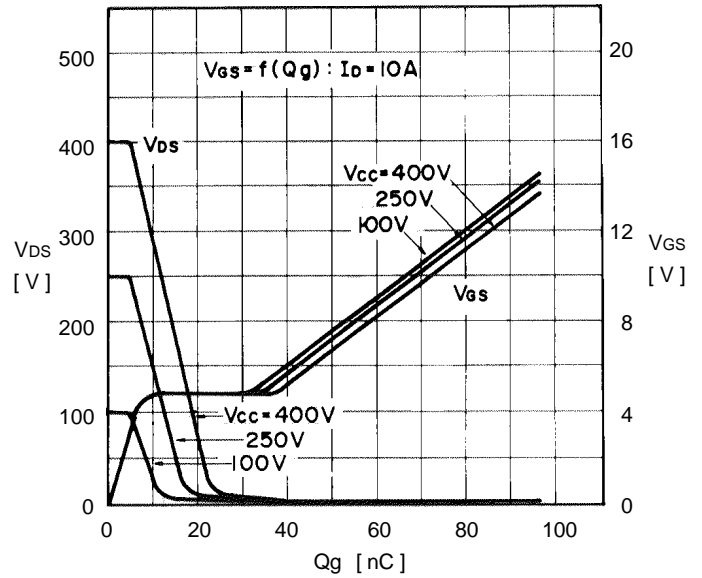
Gate threshold voltage vs. T_{ch}



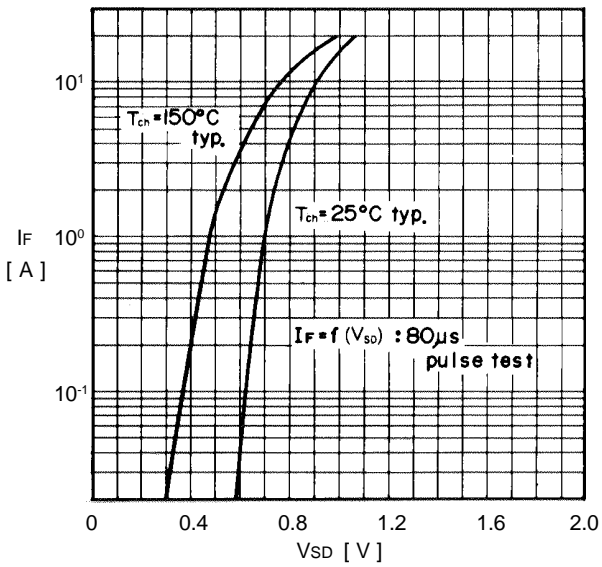
Typical capacitance vs. V_{DS}



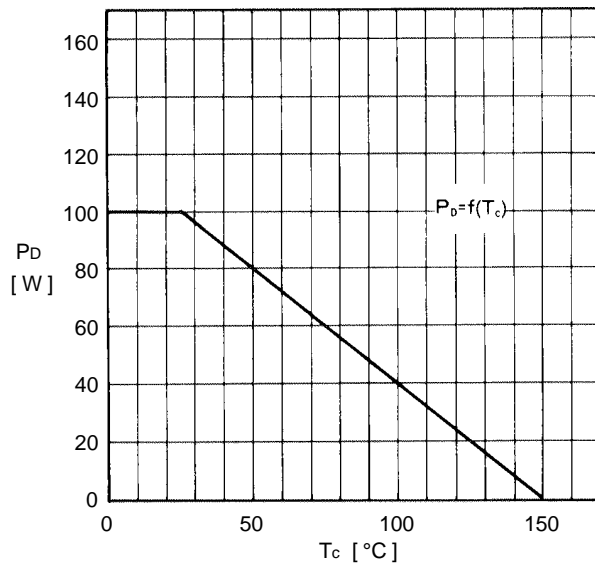
Typical input charge



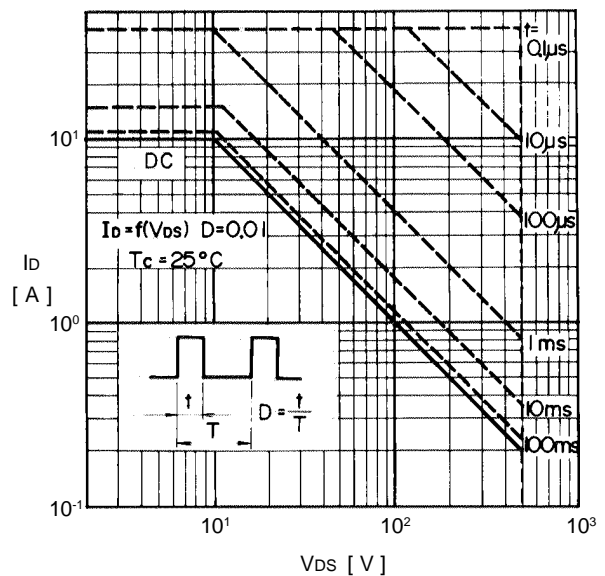
Forward characteristics of reverse diode



Allowable power dissipation vs. T_c



Safe operating area



Transient thermal impedance

